



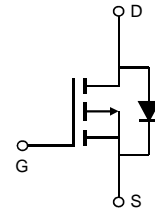
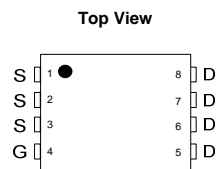
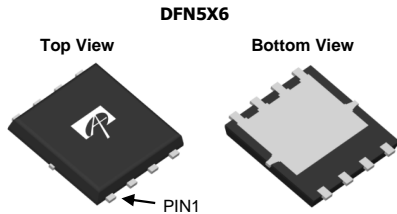
**General Description**

The AON6435 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

**Product Summary**

|                                    |                |
|------------------------------------|----------------|
| $V_{DS}$                           | -30V           |
| $I_D$ (at $V_{GS} = -10V$ )        | -34A           |
| $R_{DS(ON)}$ (at $V_{GS} = -10V$ ) | < 17m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = -5V$ )  | < 34m $\Omega$ |

100% UIS Tested  
100%  $R_g$  Tested



**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                                      | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$       | -30                     | V                |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 25$                | V                |
| Continuous Drain Current                       | $I_D$          | $T_C=25^\circ\text{C}$  | -34              |
|  |                | $T_C=100^\circ\text{C}$ | -21.5            |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$       | -95                     | A                |
| Continuous Drain Current                       | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | -12              |
|  |                | $T_A=70^\circ\text{C}$  | -10              |
| Avalanche Current <sup>C</sup>                 | $I_{AS}$       | 24                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}$       | 29                      | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$          | $T_C=25^\circ\text{C}$  | 31               |
|  |                | $T_C=100^\circ\text{C}$ | 12.5             |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 4.1              |
|  |                | $T_A=70^\circ\text{C}$  | 2.6              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                   | Symbol          | Typ          | Max | Units                     |
|---|-----------------|--------------|-----|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup>    | $R_{\theta JA}$ | 24           | 30  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A, D</sup> |                 | Steady-State | 53  | 64                        |
| Maximum Junction-to-Case                    | $R_{\theta JC}$ | 3.4          | 4   | $^\circ\text{C}/\text{W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min  | Typ      | Max      | Units |
|-----------------------------|---------------------------------------|--|------|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |      |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V  | -30  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                           |      |          | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±25V   |      |          | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                    | -1.7 | -2.3     | -3       | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V  | -95  |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A<br>T <sub>J</sub> =125°C                         |      | 13<br>19 | 17<br>25 | mΩ    |
|                             |                                       | V <sub>GS</sub> =-5V, I <sub>D</sub> =-15A   |      | 25       | 34       |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-20A   |      | 28       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V   |      | -0.73    | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |      |          | -35      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |      |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz   |      | 1130     | 1400     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  |      | 240      |          | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |  |      | 155      |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   |      | 5.8      | 8        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |      |          |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-20A                           |      | 21       |          | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |  |      | 10       |          | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |  |      | 4        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  |      | 6        |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V,<br>R <sub>L</sub> =0.75Ω, R <sub>GEN</sub> =3Ω |      | 10       |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |      | 8        |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |  |      | 15       |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |      | 7        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-20A, dI/dt=500A/μs  |      | 13.5     |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-20A, dI/dt=500A/μs  |      | 29       |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C. Maximum UIS current limited by test equipment.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

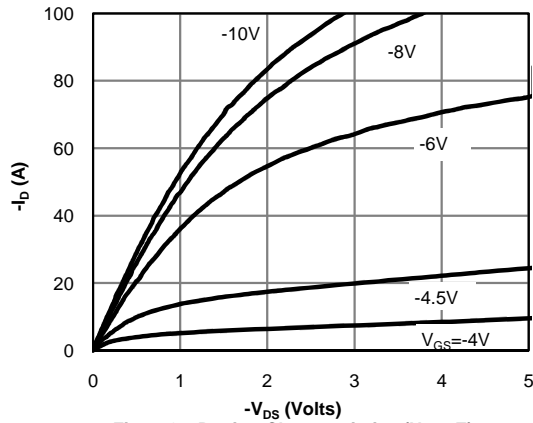
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

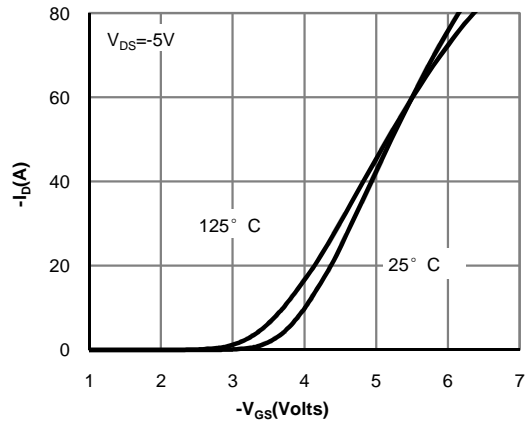
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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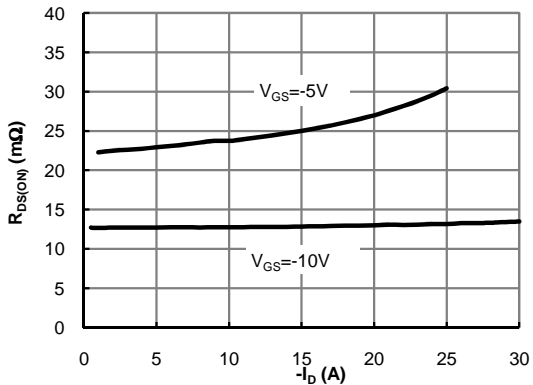
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



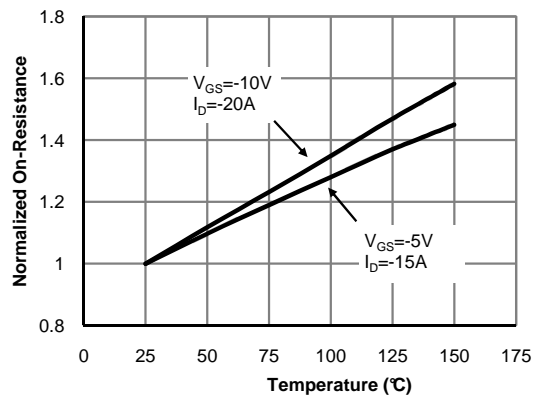
**Figure 1: On-Region Characteristics (Note E)**



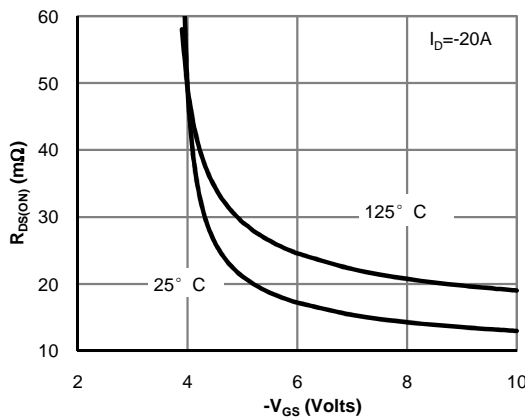
**Figure 2: Transfer Characteristics (Note E)**



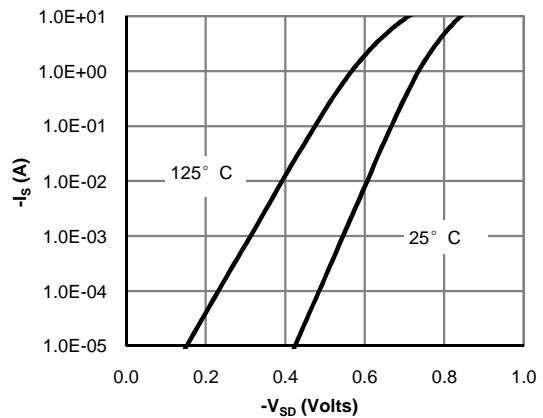
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

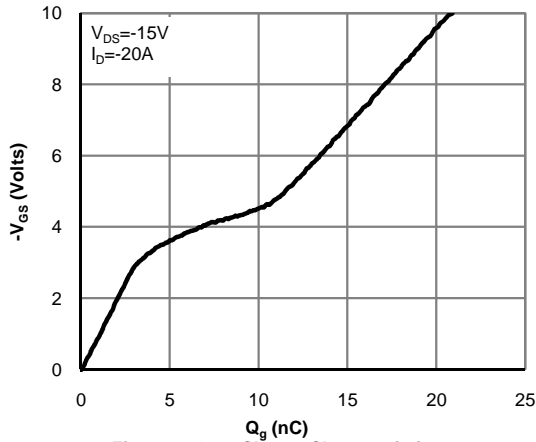


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

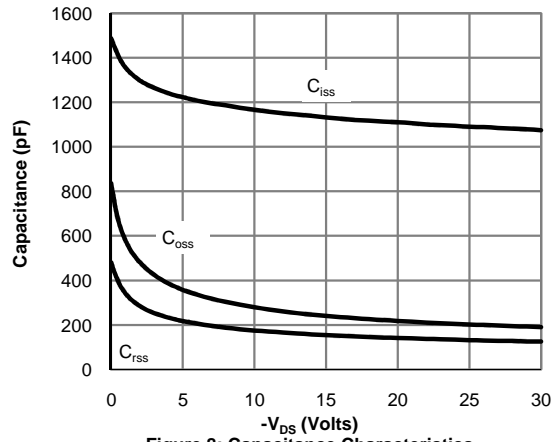


**Figure 6: Body-Diode Characteristics (Note E)**

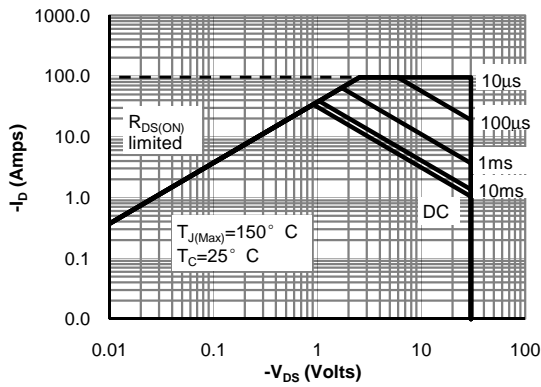
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



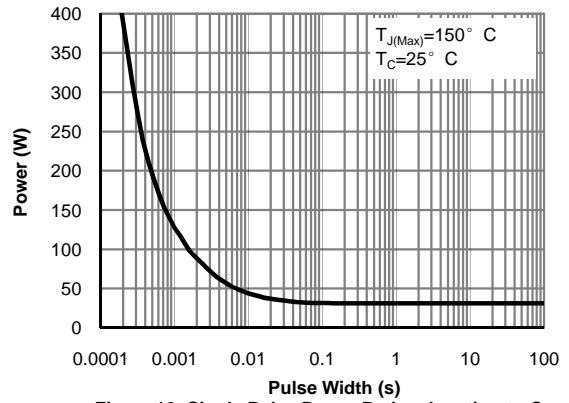
**Figure 7: Gate-Charge Characteristics**



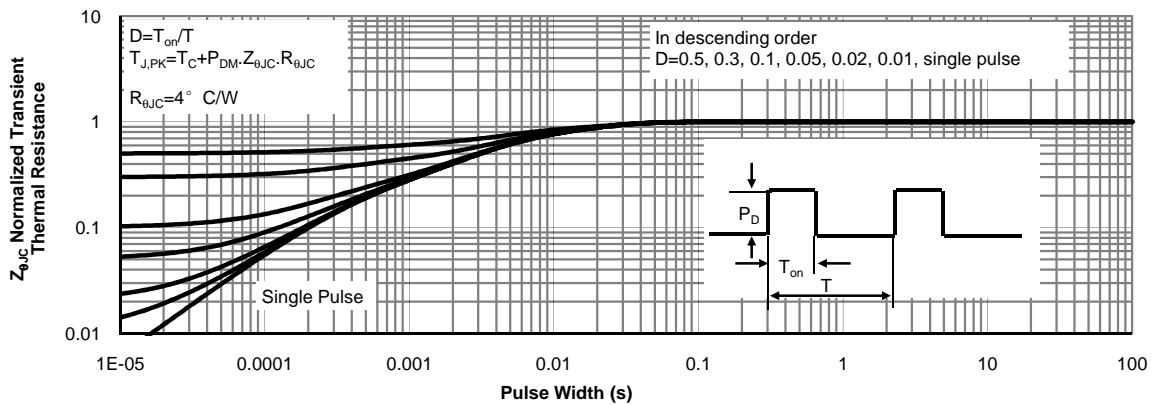
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

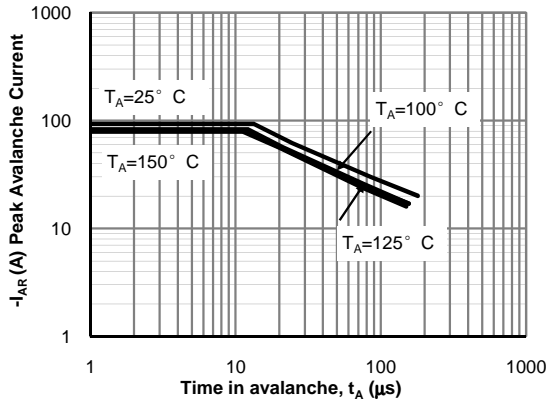


**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

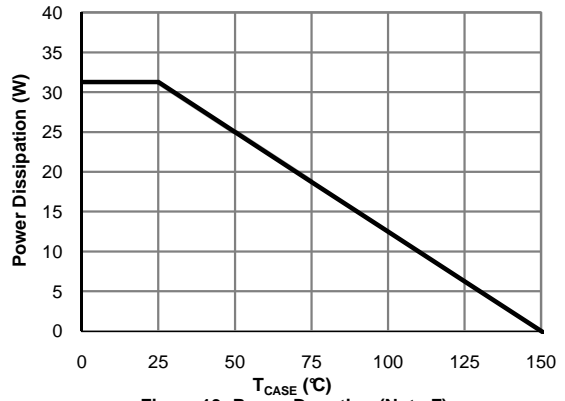


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

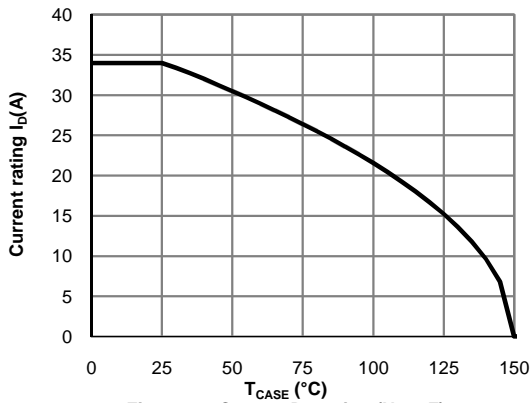
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



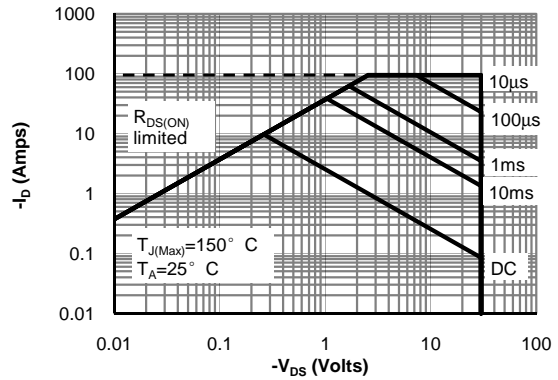
**Figure 12: Single Pulse Avalanche capability (Note C)**



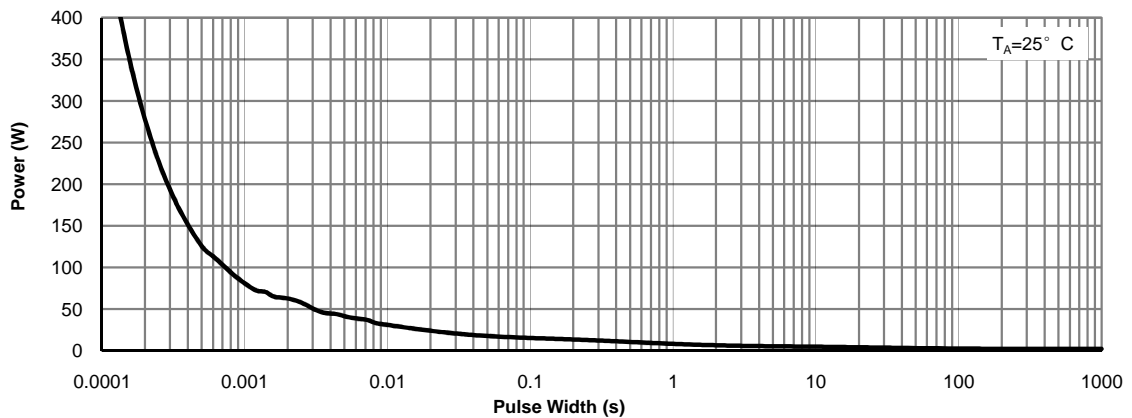
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

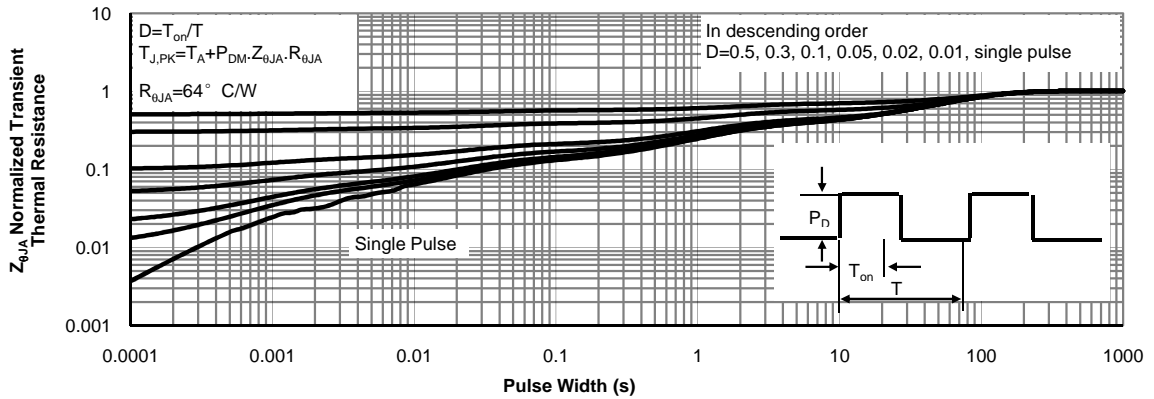


**Figure 15: Maximum Forward Biased Safe Operating Area (Note H)**



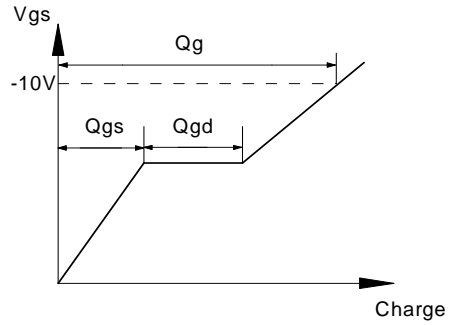
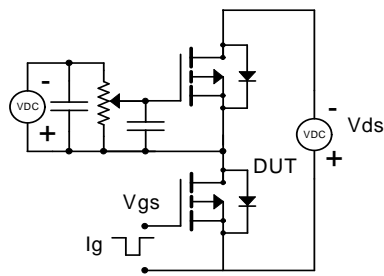
**Figure 16: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

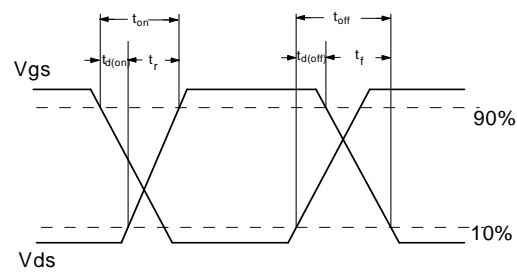
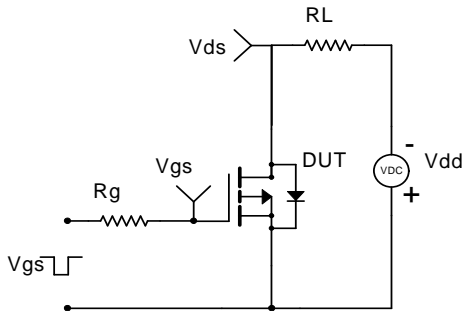


**Figure 17: Normalized Maximum Transient Thermal Impedance (Note H)**

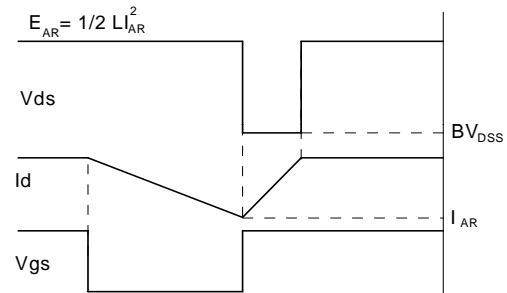
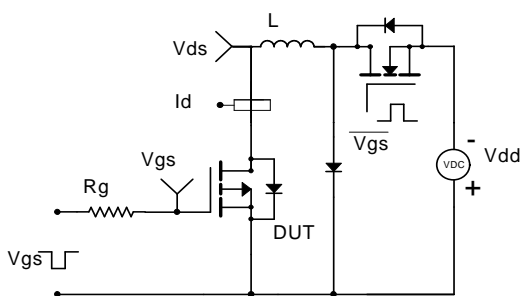
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**

